

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/772,447	SHIBA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Sow-Fun Hon	1772	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,432,610	02-1984	Kobayashi et al.	349/42
*	B	US-5,296,716	03-1994	Ovshinsky et al.	257/3
*	C	US-4,868,616	09-1989	Johnson et al.	257/63
*	D	US-6,384,435	05-2002	Aratani, Katsuhisa	257/208
*	E	US-6,549,447	04-2003	Fricke et al.	365/105
*	F	US-6,703,252	03-2004	Chen et al.	438/20
*	G	US-6,621,130	09-2003	Kurokawa et al.	257/390
*	H	US-6,700,813	03-2004	Inui, Fumihiro	365/158
*	I	US-5,523,970	06-1996	Riggio, Jr., Salvatore R.	365/185.01
*	J	US-5,694,146	12-1997	Ovshinsky et al.	345/91
*	K	US-5,335,219	08-1994	Ovshinsky et al.	369/288
*	L	US-5,821,911	10-1998	Jachimowicz, Karen E.	345/7
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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